

Notice of References Cited

Application/Control No.

10/606,623

Applicant(s)/Patent Under
Reexamination
EID ET AL.

Examiner

Devona E. Faulk

Art Unit

2615

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,035,413	04-2006	Waller et al.	381/17
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NON-PATENT DOCUMENTS

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